

## **MOSFET**

## OptiMOS<sup>™</sup> 5 Power-Transistor, 80 V

### **Features**

- Optimized for synchronous rectification
  N-channel, normal level
  Very low on-resistance R<sub>DS(on)</sub>
  Superior thermal resistance

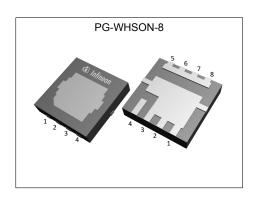
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21

### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Table 1 **Kev Performance Parameters** 

Parameter	Value	Unit
<b>V</b> <sub>DS</sub>	80	V
R <sub>DS(on),max</sub>	5.0	mΩ
I <sub>D</sub>	99	A
Qoss	40	nC
Q <sub>G</sub> (0V10V)	35	nC











Type / Ordering Code	Package	Marking	Related Links
IQE050N08NM5SC	PG-WHSON-8	E	-

# OptiMOS<sup>™</sup> 5 Power-Transistor, 80 V



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## OptiMOS<sup>™</sup> 5 Power-Transistor, 80 V IQE050N08NM5SC



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Davamatar	Cumbal	Values			1114	N
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - - -	- - -	99 70 54 16	A	$V_{GS}$ =10 V, $T_{C}$ =25 °C $V_{GS}$ =10 V, $T_{C}$ =100 °C $V_{GS}$ =6 V, $T_{C}$ =100 °C $V_{GS}$ =10V, $T_{A}$ =25°C, $R_{thJA}$ =60°C/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	396	Α	<i>T</i> <sub>A</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	184	mJ	$I_D$ =20 A, $R_{GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	100 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =60 °C/W <sup>2)</sup>
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1 55/175/56

#### 2 Thermal characteristics

Thermal characteristics Table 3

Parameter	Symbol	Values			Unit	Note / Test Condition
raiailietei	Symbol	Min.	Тур.	Max.	Ollit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	0.9	1.5	°C/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	0.7	-	°C/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area²)	R <sub>thJA</sub>	-	-	60	°C/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.  $^{2)}$  Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

4) See Diagram 13 for more detailed information

# OptiMOS<sup>™</sup> 5 Power-Transistor, 80 V IQE050N08NM5SC



### 3 Electrical characteristics

at T<sub>j</sub>=25 °C, unless otherwise specified

**Table 4** Static characteristics

Parameter	0	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	80	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA
Gate threshold voltage	V <sub>GS(th)</sub>	2.2	3.0	3.8	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=49\ \mu {\rm A}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1.0 100	μΑ	V <sub>DS</sub> =80 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =80 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	4.3 6.1	5.0 8.5	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =20 A V <sub>GS</sub> =6 V, I <sub>D</sub> =5 A
Gate resistance	R <sub>G</sub>	-	0.62	-	Ω	-
Transconductance	<b>g</b> fs	-	50	-	S	$ V_{DS}  \ge 2 I_D R_{DS(on)max}, I_D = 20 A$

Table 5 Dynamic characteristics

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Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance <sup>1)</sup>	Ciss	-	2200	2900	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =40 V, <i>f</i> =1 MHz
Output capacitance <sup>1)</sup>	Coss	-	370	480	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =40 V, <i>f</i> =1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	-	21	37	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =40 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	9.4	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	4.6	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	t <sub>d(off)</sub>	-	16.1	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	4.0	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>2)</sup>

Parameter	Ol	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	10	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	6.7	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge <sup>1)</sup>	Q <sub>gd</sub>	-	8.8	13.2	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q <sub>sw</sub>	-	12.1	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total <sup>1)</sup>	Qg	-	35	44	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V <sub>plateau</sub>	-	4.5	-	V	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	29	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V
Output charge <sup>1)</sup>	Q <sub>oss</sub>	-	40	53	nC	V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

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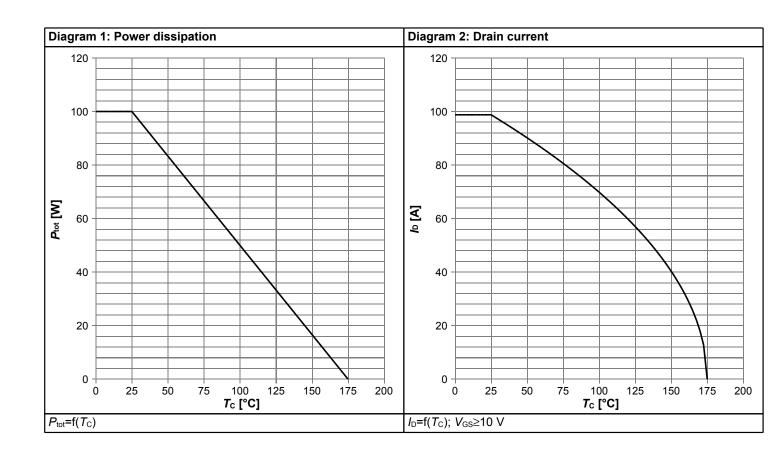


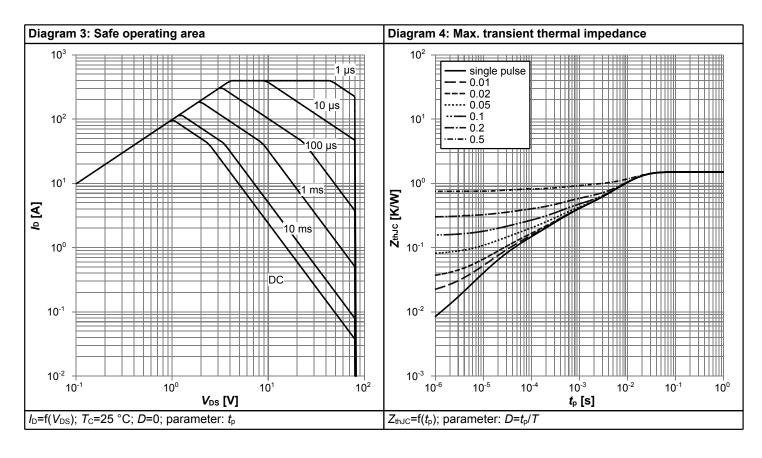
### Table 7 Reverse diode

Parameter	Cymahal	Values			11	Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	75	Α	T <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	396	Α	T <sub>C</sub> =25 °C
Diode forward voltage	V <sub>SD</sub>	-	0.83	1.1	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =20 A, T <sub>j</sub> =25 °C
Reverse recovery time <sup>1)</sup>	t <sub>rr</sub>	-	37	74	ns	V <sub>R</sub> =40 V, I <sub>F</sub> =20 A, di <sub>F</sub> /dt=100 A/μs
Reverse recovery charge <sup>1)</sup>	Qrr	-	30	60	nC	V <sub>R</sub> =40 V, I <sub>F</sub> =20 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs

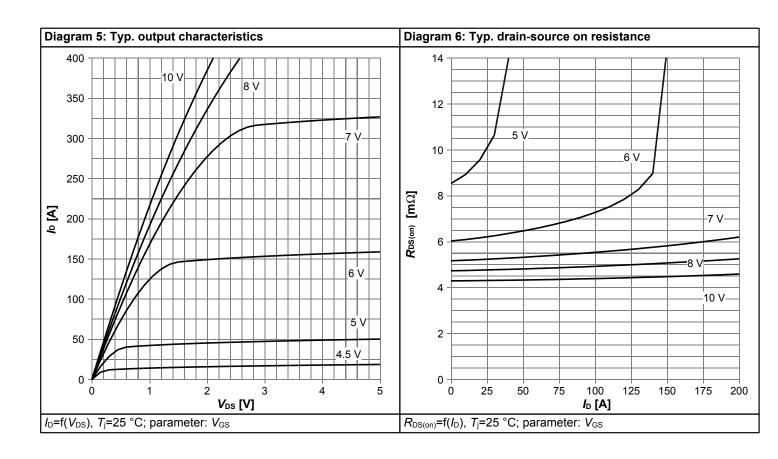


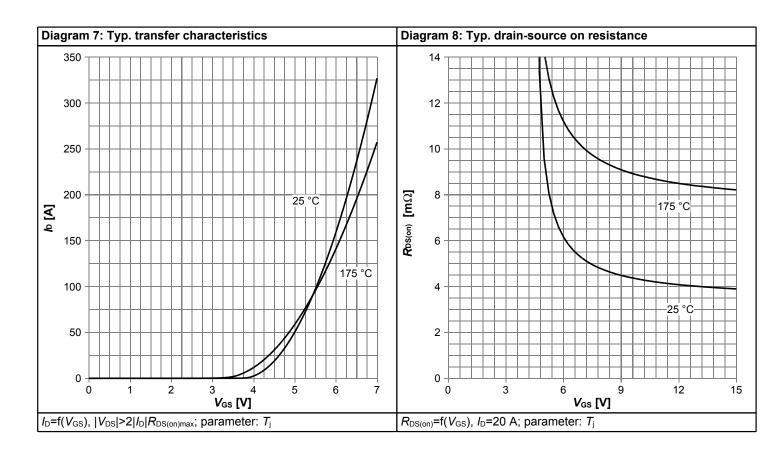
## 4 Electrical characteristics diagrams



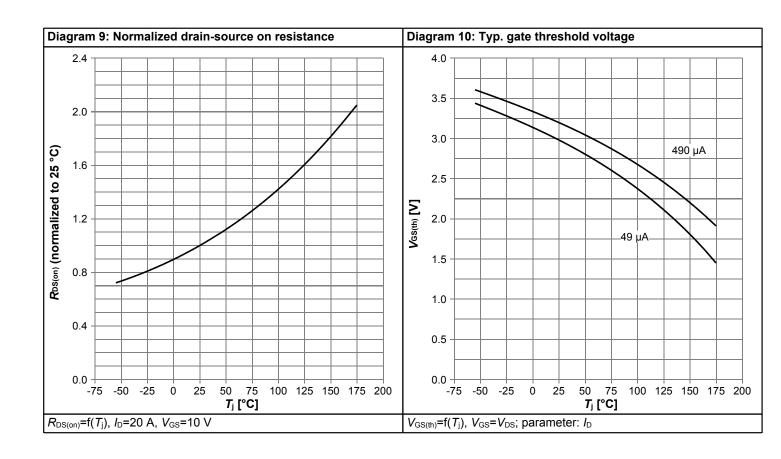


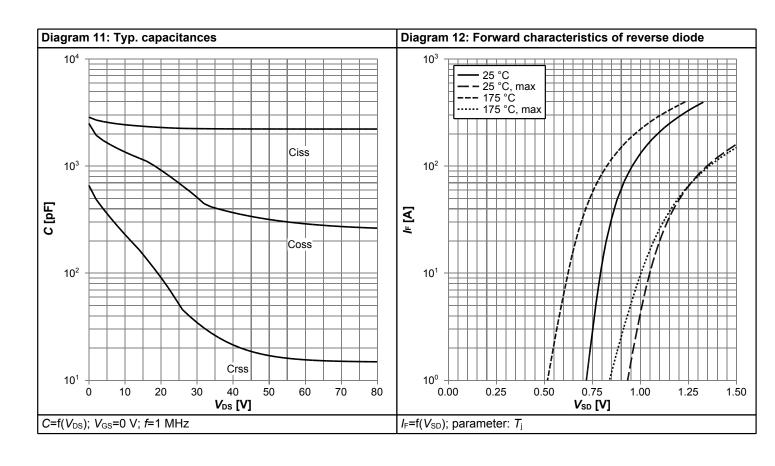




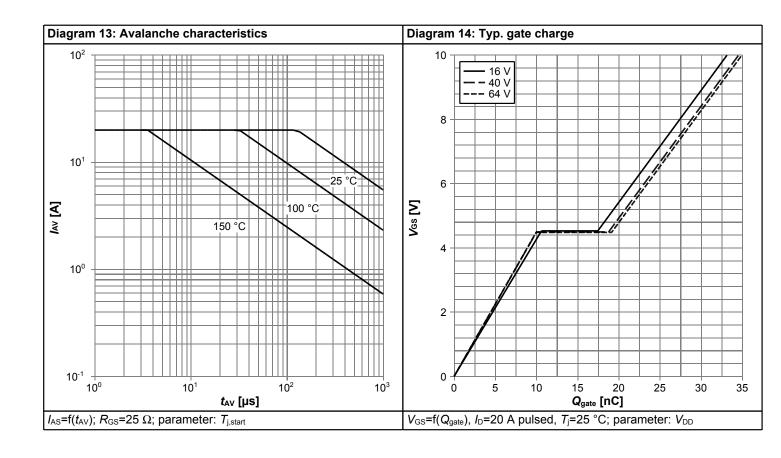


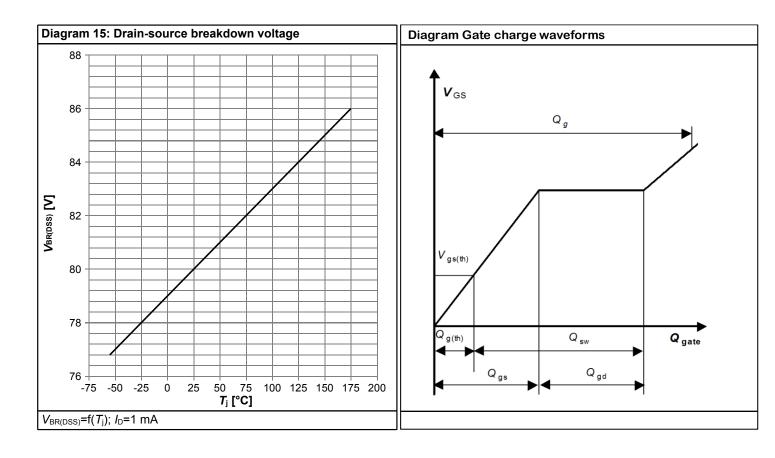






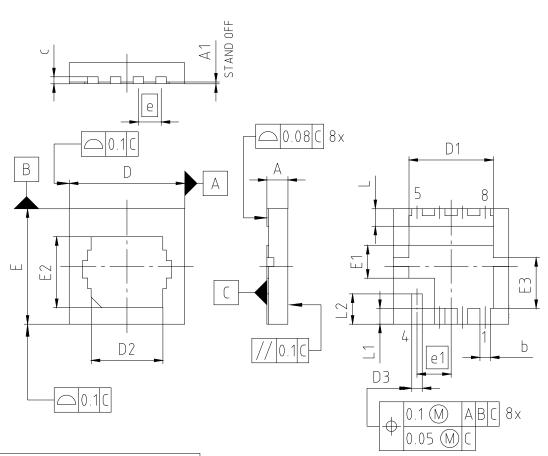








# 5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-WHS	PG-WHSON-8-U01					
DIMENSIONS	MILLIMETERS						
DIMENSIONS	MIN.	MAX.					
Α		0.75					
A1	0	0.05					
b	0.20	0.40					
С	0.10	0.30					
D	3.20	3.40					
D1	2.31	2.51					
D2	1.95	2.25					
D3	0.20	0.40					
E	3.20	3.40					
E1	0.84	1.04					
E2	1.93	2.23					
E3	1.35	1.55					
е	0.65						
e1	0.975						
L	0.40	0.60					
L1	0.35	0.55					
L2	0.77	0.97					

Figure 1 Outline PG-WHSON-8, dimensions in mm



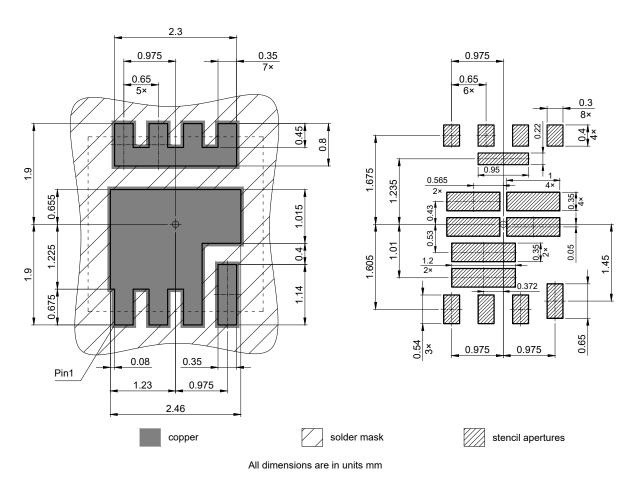


Figure 2 Outline Footprint (PG-WHSON-8-1), dimensions in mm



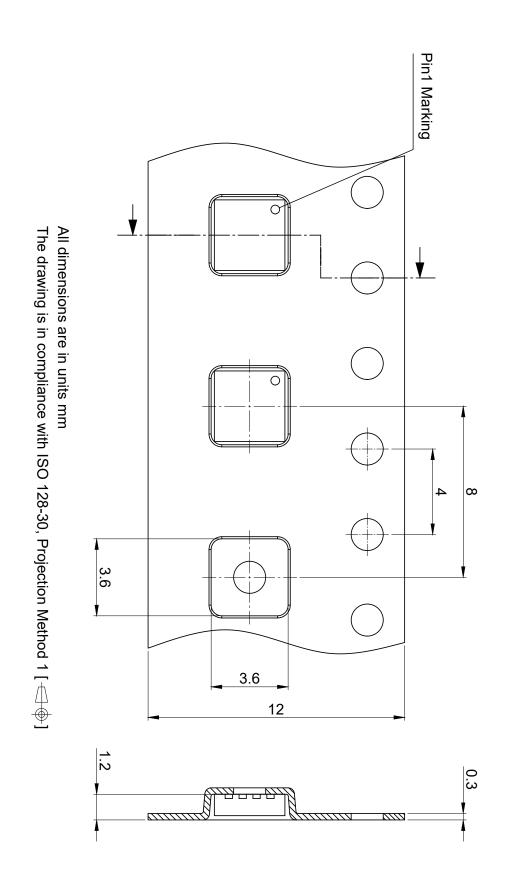


Figure 3 Outline Tape (PG-WHSON-8-1), dimensions in mm

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### **Revision History**

IQE050N08NM5SC

Revision: 2022-05-02, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2022-05-02	Release of final version

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